

Notice of References Cited	Application/Control No. 10/816,150	Applicant(s)/Patent Under Reexamination ELFADEL, IBRAHIM M.	
	Examiner Shambhavi Patel	Art Unit 2128	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Elfadel et al. 'A Comparative Study of Two Transient Analysis Algorithms for Lossy Transmission Lines With Frequency-Dependent Data'. IEEE Transactions on Advanced Packaging, Vol. 25, No. 2, May 2002.
	V	Jaijeet Royschowdhury. 'Automated Macromodel Generation for Electronic Systems'. August 2003.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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